

└ Context & Motivation

Context & Motivation

Reliability in **series systems** is like a chain's strength – determined by its weakest link.

- Essential for system design and maintenance.

Main Goal: Estimate individual component reliability from *failure data*.

Challenges:

- *Masked* component-level failure data.
- *Right-censoring* in system-level failure data.

Our Response:

- Derive techniques to interpret such ambiguous data.
- Aim for precise and accurate reliability estimates for individual components using maximum likelihood estimation (MLE) and bootstrapped (BCa) confidence intervals.

- **Chain Analogy:** Think of a series system as a chain. Its reliability, just like a chain's strength, is determined by its weakest link or component. When any component fails, the whole system does.
- **Reliability Importance:** Understanding the reliability of each component is essential for the design and maintenance of these systems.
- **Data Challenge:** The data we rely on can come with its own challenges. We sometimes encounter ambiguous data like right-censored information or masked component-level failures, where we don't know precisely which component failed.
- **Aim:** Our goal is to interpret such ambiguous data and provide accurate reliability estimates for each component, which includes providing correctly specified 95% using the BCa method.

└ Core Contributions

Core Contributions

Likelihood Model for series systems.

- Accounts for *right-censoring* and *masked component failure*.
- Can easily incorporate additional failure data.

Specifications of Conditions:

- Assumptions about the masking of component failures.
- Simplifies and makes the model more tractable.

Simulation studies:

- Components with *Weibull* lifetimes.
- Evaluate MLE and confidence intervals under different scenarios.

R Library: Methods available on GitHub.

- github.com/queelius/wei.series.md.c1.c2.c3

Our core contributions can be broken down into several parts:

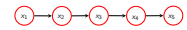
- **Likelihood model:** We've derived a likelihood model for series systems that accounts for the ambiguous data.
- **Explain conditions:** We've clarified the conditions this model assumes about the masking of component failures. These conditions simplify the model and make it more tractable.
- **Validated with simulation study:** We've validated our model with extensive simulations using Weibull distributions to gauge its performance under various scenarios.
- **R Library:** For those interested, we made our methods available in an R Library hosted on GitHub.

Reliability Estimation in Series Systems

└ Series System

└ Series System

Series System



Critical Components: Complex systems often comprise *critical* components. If any component fails, the entire system fails.

- We call such systems *series* systems.
- **Example:** A car's engine and brakes.

System Lifetime is dictated by its shortest-lived component:

$$T_s = \min(T_1, \dots, T_n)$$

- Where: T_s and T_j are the system and component lifetimes for the j^{th} system and j^{th} component, respectively.

- **Critical Components:** Many complex systems have components that are essential to their operation.
- **Series System:** If any of these components fail, the entire system fails. We call these series systems.
- **Car:** Think of a car - if the engine or brakes fail, the car can't be operated.
- **Lifetime:** Its lifetime is the lifetime of its shortest-lived component.
- **Notation:** For reference, we show the math notation we'll use throughout the talk.

Reliability Estimation in Series Systems

└ Series System

└ Reliability Function

Reliability Function

Reliability Function represents the probability that a system or component functions beyond a specified time.

- Essential for understanding longevity and dependability.

Series System Reliability: Product of the reliability of its components:

$$R_T(t; \theta) = \prod_{j=1}^m R_j(t; \theta_j)$$

- Here, $R_T(t; \theta)$ and $R_j(t; \theta_j)$ are the reliability functions for the system i and component j , respectively.

Relevance:

- Forms the foundation for most reliability studies.
- Integral to our likelihood model, e.g., right-censoring events.

- **Reliability Function** The reliability function tells us the chance a component or system functions past a specific time. It's our key metric for longevity.
- **Product of Component Reliability:** In a series system, the overall reliability is the product of its component reliabilities. So, if even one component has a low reliability, it can impact the whole system.
- **Relevance:** Why does this matter to us? This concept is foundational to our studies, especially when we're handling right-censored data.

Reliability Estimation in Series Systems

└ Series System

└ Hazard Function: Understanding Risks

Hazard Function: Understanding Risks

Hazard Function: Measures the immediate risk of failure at a given time, assuming survival up to that moment.

- Reveals how the risk of failure evolves over time.
- Guides maintenance schedules and interventions.

Series System Hazard Function is the sum of the hazard functions of its components:

$$h_T(t; \theta) = \sum_{j=1}^m h_j(t; \theta_j).$$

- Components' risks are additive.

Hazard Function: Let's shift focus to the hazard function. Essentially, it's a way to gauge the immediate risk of failure, especially if it's been functioning up until that point.

Series Hazard Function Lastly, the hazard function for a series system is just the sum of the hazard functions of its components.

Additive: We see that the component risks are additive.

Reliability Estimation in Series Systems

└ Series System

└ Joint Distribution of Component Failure and System Lifetime

Joint Distribution of Component Failure and System Lifetime

Our likelihood model depends on the **joint distribution** of the system lifetime and the component that caused the failure.

- **Formula:** Product of the failing component's hazard function and the system reliability function:

$$f_{K_i, T}(j, t; \theta) = h_j(t; \theta_j) R_T(t; \theta).$$

- **Single Point of Failure:** A series system fails due to one component's malfunction.
- **Representation:**
 - K_i : Component causing the i^{th} system's failure.
 - $h_j(t; \theta_j)$: Hazard function for the j^{th} component.

- **Joint Distribution** In our likelihood model, understanding the joint distribution of a system's lifetime and the component that led to its failure is fundamental.
- **Formula:** It is the product of the failing component's hazard function and the system reliability function.
- **Unique Cause:** Which emphasizes that in a series system, failure can be attributed to a single component's malfunction.
- **Notation:** Here, K_i denotes the component responsible for the failure.

Reliability Estimation in Series Systems

└ Series System

└ Component Failure & Well-Designed Series Systems

Component Failure & Well-Designed Series Systems

The **marginal probability** of component failure helps predict the cause of failure.

- **Derivation:** Marginalize the joint distribution over the system lifetime:

$$\Pr\{K_i = j\} = E_{\theta} \left[\frac{h_j(T_i; \theta)}{h_T(T_i; \theta)} \right]$$

Well-Designed Series System: Components exhibit comparable chances of causing system failures.

- **Relevance:** Our simulation study employs a (reasonably) well-designed series system.

- **Marginal:** We can use this joint distribution to calculate the marginal probability of component failure.
- **Expected Value:** When we do so, we find that it is the expected value of the ratio of component and system hazard functions.
- **Well-Designed:** We say that a series system is *well-designed* if each component has a comparable chance of failing.
- **Relevance:** Our simulation study is based on a reasonably well-designed series system.

Reliability Estimation in Series Systems

└ Likelihood Model

└ Likelihood Model

Likelihood Model

Likelihood measures how well our model parameters (θ) explain the data. Each system contributes to the **total likelihood** via its *likelihood contribution*:

$$L(\theta|\text{data}) = \prod_{i=1}^n L_i(\theta|\text{data}_i)$$

where **data_i** is the data for the i^{th} system and L_i is its contribution.

Our model handles the following data: **Right-Censored:** Experiment ends before failure (Event Indicator: $\delta_i = 0$). - Contribution is system reliability: $L_i(\theta) = R_T(\tau; \theta)$. **Masked Failure:** Failure observed, but the failed component is masked by a candidate set. More on its contribution later.

| System | Right-Censored Lifetime | Event Indicator | Candidate Set |
|--------|-------------------------|-----------------|---------------|
| 1 | 1.1 | 1 | {1, 2} |
| 2 | 5 | 0 | \emptyset |

Let's talk about the likelihood model, which is a way of measuring how well our model explains the data.

- **Total likelihood** is the product of the likelihood contributions of each system.
- **Contributions:** Our likelihood model deals with right-censoring and masked cause of failure.
- **Right-Censoring** occurs when the experiment ends before the system fails. Its contribution is just the system reliability, since the event indicator tells us if the system was right-censored.
- **Masking** occurs when we observe a failure but we don't know the precise component cause. Instead, we observe a candidate set of components that could have failure. More on this later.
- Here's an example of observed data.
- **System 1:** We see that the system failed at 1.1. We don't know which component failed, but we know it was either component 1 or 2.

Reliability Estimation in Series Systems

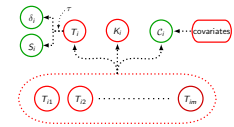
└ Likelihood Model

└ Data Generating Process

Data Generating Process

DGP is underlying process that generates the data:

- **Green** elements are observed, **Red** elements are latent.
- **Right-Censored lifetime:** $S_i = \min(T_i, r)$.
- **Event Indicator:** $\delta_i = 1_{\{T_i < r\}}$.
- **Candidate Set:** C_i related to components (T_{ij}) and other unknowns.



- **DGP:** Let's discuss the data generating process to motivate our model.
- **Graph:** Here's the graph: green is observed and red is latent.
- **Infer:** We don't get to see the red elements, but we can infer most of them from the green elements.
- **Green:** So, let's focus on the green elements.
- **Right-censoring** time is the minimum of the system lifetime and the right-censoring time.
- **Event** indicator is 1 if the system fails before the right-censoring time, 0 otherwise.
- The candidate sets are related to the component lifetimes and many other factors.
- **Difficult** to model. Seek a simple model that is valid under certain assumptions, which we discuss next.

Reliability Estimation in Series Systems

└ Likelihood Model

└ Likelihood Contribution: Masked Failure Conditions

Likelihood Contribution: Masked Failure Conditions

The candidate sets that **mask** the failed component are assumed to satisfy the following conditions:

Candidate Set Contains Failed Component: The candidate set includes the failed component.

Equal Probabilities Across Candidate Sets: The probability of the candidate set is constant across different components within it.

Masking Probabilities Independent of Parameters: The masking probabilities when conditioned on the system lifetime and the failed component aren't functions of the system parameter.

- Reasonable conditions in many industrial settings.

- The right-censoring contribution is straightforward. But the masked failure contribution is a bit more complicated.
- **Masking** occurs when a system fails but the precise failed component is masked by a candidate set.
- **Tractable:** To make problem more tractable, we introduce certain conditions.
- **Condition 1:** The candidate set always includes the failed component.
- **Condition 2:** The probability of the candidate set is constant across different components within it.
- **Condition 3:** The masking probabilities when conditioned on the system lifetime and the failed component aren't functions of the system parameter.
- **Reasonable:** These conditions are often reasonable.

Reliability Estimation in Series Systems

└ Likelihood Model

└ Likelihood Contribution: Derivation for Masked Failures

Likelihood Contribution: Derivation for Masked Failures

Take the joint distribution of T_i , K_i , and C_i and marginalize over K_i :

$$f_{T_i, C_i}(t_i, c_i; \theta) = \sum_{j=1}^m f_{T_i, K_i}(t_i, j; \theta) \Pr_{\theta}(C_i = c_i | T_i = t_i, K_i = j).$$

Apply Condition 1 to get a sum over candidate set:

$$f_{T_i, C_i}(t_i, c_i; \theta) = \sum_{j \in \mathcal{C}_i} f_{T_i, K_i}(t_i, j; \theta) \Pr_{\theta}(C_i = c_i | T_i = t_i, K_i = j).$$

Apply Condition 2 to move probability outside the sum:

$$f_{T_i, C_i}(t_i, c_i; \theta) = \Pr_{\theta}(C_i = c_i | T_i = t_i, K_i = j) \sum_{j \in \mathcal{C}_i} f_{T_i, K_i}(t_i, j; \theta).$$

Apply Condition 3 to remove the probability's dependence on θ :

$$f_{T_i, C_i}(t_i, c_i; \theta) = \beta_i \sum_{j \in \mathcal{C}_i} f_{T_i, K_i}(t_i, j; \theta).$$

Result: $L(\theta) \propto \sum_{i \in \mathcal{C}_i} f_{T_i, K_i}(t_i, j; \theta) = R_{T_i}(t_i; \theta) \sum_{j \in \mathcal{C}_i} h_j(t_i; \theta).$

- **Derive:** Here, we derive the likelihood contribution for masked failures.
- **Joint:** To start, we use the joint distribution of the system lifetime, the failed component, and the candidate set.
- **Marginalize:** We marginalize over the failed component, since we don't know which component failed.
- Apply Condition 1 to get a sum over the candidate set instead.
- Apply Condition 2 to move the probability outside the sum.
- Apply condition 3 to remove the probability's dependence on θ .
- The result: the likelihood contribution is proportional to the product of the system reliability and the sum of the component hazards in the masking set.

Reliability Estimation in Series Systems

└ Likelihood Model

└ Methodology: Maximum Likelihood Estimation

Methodology: Maximum Likelihood Estimation

Maximum Likelihood Estimation (MLE): Maximize the likelihood function:

$$\hat{\theta} = \arg \max_{\theta} L(\theta).$$

Solution: Numerically solved system of equations for $\hat{\theta}$:

$$\nabla_{\theta} \log L(\hat{\theta}) = 0.$$

- **MLE:** We use the standard MLE approach.
- **ArgMax:** We find the parameter values that maximize the log-likelihood function.
- **Solution:** Since there is no closed-form solution, we numerically solve it.

Reliability Estimation in Series Systems

└ Likelihood Model

└ Bootstrap Confidence Intervals (CIs)

Bootstrap Confidence Intervals (CIs)

Confidence Intervals (CI) quantify the uncertainty in our estimate. Asymptotic Sampling Distribution of MLE is a popular choice for constructing CIs.

- **Challenge:** Asymptotic distribution may not be accurate for small sample sizes.
 - Particularly since we're dealing with right-censoring and masking.

Bootstrapped CIs: Resample data and obtain MLE for each.

- Use percentiles of bootstrapped MLEs for CIs.

Correctly Specified CIs:

- **Desired:** Coverage probability near 95%. (> 90% acceptable.)
- **Challenge:** Actual coverage may deviate.

BCa adjustments counteracts bias and skewness in estimates.

- **Goal:** Need a way to measure the uncertainty in our estimate.
- **CIs** are a popular; they help us pin down the likely range of values for our parameters.
- **Bootstrap** the CIs, since there is a lot of bias and variability in our estimate due to the masking and censoring in our small data sets and the asymptotic distribution is not likely to be accurate.
- **Specified:** We want our CIs to be correctly specified, meaning they cover the true parameter value around 95
- **BCa:** But they may be too low or too high; we use the BCa method to adjust for bias and skewness in the estimate. A coverage probability above 90% is acceptable.

Reliability Estimation in Series Systems

└ Likelihood Model

└ Challenges with MLE on Masked Data

Challenges with MLE on Masked Data

We discovered some challenges with the MLE.

Convergence Issues: Flat likelihood regions were observed due to the ambiguity in the masked data and small sample sizes.

Bootstrap Issues: Bootstrap relies on the Law of Large Numbers.

- It might not represent the true variability for small samples.
- Due to censoring and masking, the effective sample size is reduced.

Mitigation: In simulation study, we discard non-convergent samples for the MLE on original data, but keep all resamples for the bootstrap.

- Helps ensure robustness of the results, while acknowledging the inherent complexities introduced by masking and censoring.
- We report convergence rates in our simulation study.

Like any model, ours has its challenges:

- **Masking:** Masking and censoring, combined with small sample sizes, can cause flat likelihood regions, which can lead to convergence issues.
- **Small:** For small samples, bootstrapping may not always capture the true variability in the data **Approach:** We take the following approach in our simulation study. **Discard:** We discard non-convergent samples for the MLE on original data but retain all MLEs for the resampled data. **Robustness:** This helps ensure the robustness of our results while acknowledging the inherent complexities introduced by masking and censoring. **Convergence Rate:** We report the convergence rate in our simulation study.

Reliability Estimation in Series Systems

└ Simulation Study

└ Series System: Weibull Components

Series System: Weibull Components

The lifetime of the j^{th} component in the i^{th} system:

$$T_{ij} \sim \text{Weibull}(k_j, \lambda_j)$$

- λ_j is the **scale** parameter
- k_j is the **shape** parameter:
 - $k_j < 1$: Indicates infant mortality.
 - $k_j = 1$: Indicates random failures.
 - $k_j > 1$: Indicates wear-out failures.

Recall that for a series system:

- **Series Reliability** is the product of the component reliabilities.
- **Hazard** is the sum of the component hazard functions.
- **Likelihood**: $L(\theta) \propto \prod_{i=1}^n R_T(t_i; \theta) \left[\sum_{j \in C_i} h_j(t_i; \theta) \right]^{k_i}$.

- **Weibull**: We model a series system with Weibull components.
- **Component Functions**: Hazard and reliability functions are well-known for Weibull.
- **Shape** parameter tells us a lot about the failure characteristics.
- **Increasing**: When the function is increasing, think of it as wearing-out over time.
- **Decreasing**: If it's decreasing, it usually signals some early-life challenges.
- **Series System**: Recall that for a series system, the reliability is the product of the component reliabilities and the hazard function is the sum of the component hazard functions.
- **Likelihood**: The likelihood is the same as before, we've just reproduced it here.

Reliability Estimation in Series Systems

└ Simulation Study

└ Well-Designed Series System

Well-Designed Series System

Simulation study centered around series system with Weibull components:

| Component | Shape | Scale | $\Pr(K_i)$ |
|-----------|-------|--------|------------|
| 1 | 1.26 | 994.37 | 0.17 |
| 2 | 1.16 | 908.95 | 0.21 |
| 3 | 1.13 | 840.11 | 0.23 |
| 4 | 1.18 | 940.13 | 0.20 |
| 5 | 1.20 | 923.16 | 0.20 |

- Based on (Guo, Niu, and Szidarovsky 2013) which studies a 3-component series system.
 - We add components 4 and 5 to make the system more complex.
- **Probabilities** are comparable: it is *reasonably well-designed*.
 - Component 1 is most reliable, component 3 is least reliable.
- **Shape** parameters are greater than 1, indicating wear-out failures.

- **Centered**: This study is centered around a series system with Weibull components.
- **Based**: It's based on a paper that studies a 3-component series system.
- **Added**: We added components 4 and 5 to make it more complex.
- **Probability**: We show the probability of each component being the cause of failure.
- **Well-Designed**: The probabilities are comparable, so no weak links. It's reasonably well-designed. Component 1 is most reliable, component 3 is least.
- **Parameters**: We show the shape and scale parameters for each component.
- **Wear-Out**: The shape parameters are greater than 1, indicating components are likely to fail due to wear-out.

Latent Component Lifetimes are generated for each system in the study.

Right-censoring: In our simulation study, we independently control the probability q (quantile) of right-censoring by finding the value τ that satisfies $\Pr\{T_i < \tau\} = q$.

$$S_i = \min(T_i, \tau) \text{ and } \delta_i = \mathbb{1}_{\{T_i < \tau\}}.$$

Masking Component Failures: The Bernoulli Masking Model is used to mask component cause of failure, parameterized by masking probability p .

- p chosen independently: at the extremes, if $p = 0$ there is no masking, and if $p = 1$, there is total masking.
- We describe the process and how it satisfies the masking conditions next.

- **Data Generation:** We generate the latent component lifetimes for the series system we just discussed.
- **Observed Data:** Then, we generate the data we actually see, which is based on the component data.
- **Right-Censoring:** We control the probability of right-censoring by finding the value of τ that satisfies the quantile q . Then, we set the right-censoring time to be the minimum of the system lifetime and τ . The event indicator is 1 if the system fails before τ , 0 otherwise.
- **Masking:** We use a Bernoulli masking model to mask the component cause of failure. We parameterize the level of masking by the masking probability, p .
- We parameterize the level of masking by the masking probability, p , which specifies that each non-failed component has a p probability of masking the failed component by including it in the candidate set.

We generate the candidate sets for each system in the study.

Satisfying Masking Conditions:

- **Condition 1:** The failed component deterministically placed in candidate set.
- **Condition 2:** By using a Bernoulli distribution with a constant probability p for all components, probability of a candidate set is constant as we vary which component failed within set.
- **Condition 3:** Masking only depends on the fixed parameter p and doesn't interact with the system parameter θ .

- **Masking:** We use a Bernoulli masking model for masking the failed component.
- This satisfies the masking failure conditions in the following ways:
- **Condition 1:** The failed component is deterministically placed in the candidate set.
- **Condition 2:** The probability of masking is the same for all components, so the probability of the candidate set is constant across components.
- **Condition 3:** The masking probability is independent of the parameters.

Objective: Evaluate the MLE and BCa confidence intervals' performance across various scenarios.

- **MLE Evaluation:**
 - **Accuracy:** Proximity of the MLE's expected value to the actual value.
 - **Precision:** Consistency of the MLE across samples.
- **BCa Confidence Intervals Evaluation:**
 - **Accuracy:** Confidence intervals (CIs) should cover true parameters around 95% of the time.
 - ✦ Coverage probability (CP)
 - **Precision:** Assessed by the width of the CIs.

Both accuracy and precision are crucial for confidence in the analysis.

- **Objective:** We want to evaluate the performance of the MLE and BCa confidence intervals across various scenarios.
- **MLE Evaluation:** We evaluate the MLE in terms of accuracy and precision.
- **Accuracy:** Accuracy is the proximity of the MLE's expected value to the actual value.
- **Precision:** Precision is the consistency of the MLE across samples.
- **BCa Confidence Intervals Evaluation:** We evaluate the BCa confidence intervals in terms of accuracy and precision.
- **Accuracy:** Accuracy is measured by the coverage probability, which is the proportion of times the confidence interval covers the true parameter.
- **Precision:** Precision is assessed by the width of the confidence interval.
- Both accuracy and precision are crucial for confidence in the analysis.